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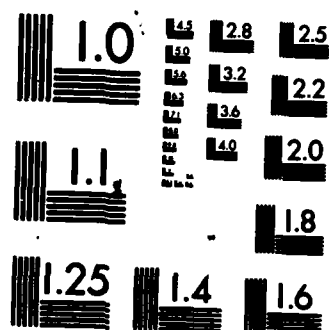
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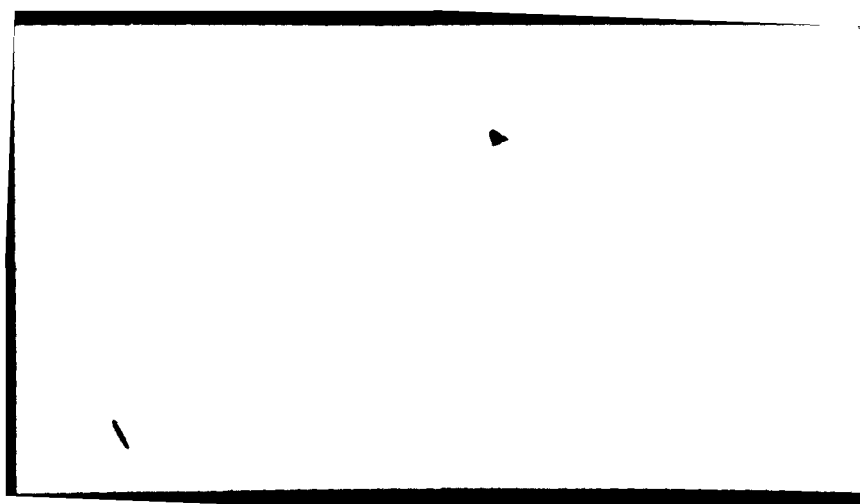
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**THE PMC SYSTEM LEVEL FAULT MODEL:  
MAXIMALITY PROPERTIES OF  
THE IMPLIED FAULTY SETS**

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**Report JHU/EECS-83/03**

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**May 15, 1983**

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**This work was supported by the Office of Naval Research under Contract  
N00014-80-C-0772.**

ABSTRACT

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In this paper, we examine the implied faulty sets in the case of the PMC system level fault model. We show that those sets possess a maximality property whenever: the system is one-step  $r$ -diagnosable, no two modules test each other and the number of faulty modules is no larger than  $r$ . In addition, we propose a syndrome-decoding algorithm based on that maximality property.

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## INTRODUCTION

Since its introduction in 1967, the *PMC* system level fault model proposed by Preparata, Metze and Chien [9] has been the subject of much attention. Conditions that insure one-step  $\tau$ -diagnosability have been proposed in [1], [3] and [9], and decoding algorithms have been proposed in [2] and in [4]-[8].

One of the major stumbling blocks for the synthesis of decoding algorithms for the *PMC* model is the absence of known useful properties that result from the assumptions of the model. Thus, the existing algorithms depend either on strong assumptions on the structure of the testing interconnection [5], [7], on unproven conjectures [2], or on searches with the associated drawback -- namely, backtracking [4] -- or they are insured to work only when few faults are present [6] [8].

It seems reasonable to assume that if a *PMC* model is one-step  $\tau$ -diagnosable, then well-chosen quantities exist that exhibit useful properties. In previous work [5]-[8], we used the concept of the *implied faulty set* to analyze the *PMC* model. The implied faulty set of a module is simply the set of all the modules in the system that may be deduced to be faulty under the assumption that the module is non faulty. The usefulness of this concept has been demonstrated in [5] and [7] for the case of  $D_{\lambda, \tau}$  interconnection structures, and in [6] and [8] for the case in which no two modules test each other, and the number of faulty modules is small.

In this paper, we show that the implied faulty sets of one-step  $\tau$ -diagnosable *PMC* models in which no two modules test each other satisfy a *principle of optimality*: the module that corresponds to a maximal implied faulty set is always faulty.

## THE PMC SYSTEM LEVEL FAULT MODEL

Consider a system  $S$  of  $n$  modules  $U_0, U_1, \dots, U_{n-1}$  and a testing interconnection design  $TID = \{(i, j) \mid U_i \text{ tests } U_j\}$ . It is assumed that when  $(i, j)$  is in  $TID$ , the test outcome  $a_{i,j}$  of  $U_i$  testing  $U_j$  is  $a_{i,j} = 0$  if  $U_i$  believes  $U_j$  to be nonfaulty, and  $a_{i,j} = 1$  if  $U_i$  believes  $U_j$  to be faulty. A complete set of test outcomes, i.e., an outcome  $a_{i,j}$  for each  $(i, j)$  in  $TID$  is called a *syndrome*. The diagnosis problem consists in partitioning  $S$  into the set  $G_S$  of non faulty modules and the set  $F_S$  of faulty modules from the knowledge of one of the possible corresponding syndromes. In this paper, we assume that the only faults that may occur are solid, and that the test-fault relationship satisfies at least the Preparata-Metze-Chien assumption given below.

### *Hypothesis 1:*

- (i) If  $(i, j)$  is in  $TID$  and  $U_i$  is nonfaulty, then  $a_{i,j} = 0$  implies that  $U_j$  is non-faulty, and  $a_{i,j} = 1$  implies that  $U_j$  is faulty;
- (ii) If  $(i, j)$  is in  $TID$  and  $U_i$  is faulty, then  $U_j$  may be nonfaulty or faulty regardless of the value of  $a_{i,j}$ .

Given  $(G_S, F_S)$ , Hypothesis 1 implies that only a subset of all possible syndromes may occur. Determining all possible syndromes that correspond to a given partition  $(G_S, F_S)$  of  $S$  is not difficult. On the other hand, the problem we address in this paper -- that is, given a syndrome produced by a partition  $(G_S, F_S)$  of  $S$ , find  $(G_S, F_S)$  -- is much more difficult to solve.

Not all the partitions of  $S$  into nonfaulty and faulty modules may explain a given syndrome. A partition  $(G, F)$  of  $S$  is *consistent* with a given syndrome if and only if the assumption that all the modules in  $G$  are nonfaulty and all the modules in  $F$  are faulty is consistent with the syndrome. The partition  $(G_S, F_S)$

is obviously consistent, but unfortunately, many partitions usually exist that are consistent with any given syndrome. Thus, given a syndrome, one cannot identify the faulty modules without additional assumptions.

If we assume that the *a priori* probability that a set of modules  $F$  is faulty is inversely proportional to the cardinality  $|F|$  of  $F$ , then it is reasonable to look for the consistent partitions of  $S$  that are most likely to occur: namely, the consistent partitions of  $S$  in which  $|F|$  is minimal. Such partitions, called *minimal consistent partitions* are the solutions to the following discrete minimization problem.

**Problem 1:** Given a syndrome, find a consistent partition  $(G_{\#}, F_{\#})$  of  $S$  such that  $|F_{\#}| \leq |F|$  for all the partitions  $(G, F)$  of  $S$  that are consistent with the syndrome.

If the number of faulty modules does not exceed  $\tau$ , at least one consistent partition, namely  $(G_S, F_S)$ , exists such that  $|F_S| \leq \tau$ . If only one such partition exists, then finding the partition  $(G_S, F_S)$  reduces to solving Problem 1 whenever  $|F_S| \leq \tau$ . Thus, in the context of our paper, one-step  $\tau$ -diagnosability [9] reduces to:

**Definition 1:** A system  $S$  is one-step  $\tau$ -diagnosable if and only if whenever a consistent partition  $(G, F)$  exists such that  $|F| \leq \tau$ , that partition is the unique solution to Problem 1.

## IMPLIED NON-FAULTY AND FAULTY SETS

We have reduced the problem of identifying the partition  $(G_S, F_S)$  to that of solving a discrete minimization problem, Problem 1. Our approach to this problem depends on the concepts of implied non faulty and faulty sets.



**Definition 2:** The implied non faulty set  $M(U_i)$  of a module  $U_i$  (with respect to a given syndrome) is the set of all the modules in  $S$  that may be deduced to be non faulty under the assumption that  $U_i$  is non faulty.

**Definition 3:** The implied faulty set  $L(U_i)$  of a module  $U_i$  (with respect to a given syndrome) is the set of all the modules in  $S$  that may be deduced to be faulty under the assumption that  $U_i$  is non faulty.

If the module  $U_i$  is in  $G_S$ , then  $M(U_i)$  is a subset of  $G_S$ ,  $L(U_i)$  is a subset of  $F_S$ , and therefore,  $M(U_i)$  and  $L(U_i)$  are disjoint. Thus, if  $M(U_i)$  and  $L(U_i)$  are not disjoint, we may conclude that  $U_i$  is in  $F_S$ . Let  $F_0$  and  $G_0$  be the sets defined by

$$F_0 = \{ U_i \in S \mid M(U_i) \cap L(U_i) \neq \phi \},$$

and

$$G_0 = S - F_0.$$

The set  $F_0$  is a subset of  $F_S$ , provided that the basic assumption on the fault-test relationship, namely Hypothesis 1, holds. The fact that  $F_0$  is a subset of  $F_S$  does not depend on any assumption concerning the maximum number of faulty modules, nor on assumptions concerning the structure of the testing interconnection network. The set  $F_0$  is not difficult to obtain. Given a system  $S$  and a syndrome, we may compute  $F_0$  and consider the reduced system  $S_0$  obtained by deleting  $F_0$  from  $S$  and the corresponding reduced syndrome obtained by deleting all the tests links between  $G_0$  and  $F_0$  from the original syndrome. Note that if  $S$  is one-step  $r$ -diagnosable, then  $S_0$  is one-step  $(r - |F_0|)$ -diagnosable.

Clearly, if Hypothesis 1 is satisfied and if  $L(U_i) \cap G_0 = \phi$  for every

module  $U_i$  in  $G_0$ , then the partition  $(G_0, F_0)$  is a solution to Problem 1. Thus, Definition 1 implies that, in some cases, the set  $F_S$  of faulty modules is the set  $F_0$ .

**Lemma 1:** If Hypothesis 1 is satisfied, if  $S$  is one-step  $\tau$ -diagnosable, if  $L(U_i) \cap G_0 = \emptyset$  for every module  $U_i$  in  $G_0$ , and if  $|F_0| \leq \tau$ , then  $F_S = F_0$ .

### MAXIMALITY OF THE IMPLIED FAULTY SETS

The set  $F_0$  may be computed as soon as the implied non faulty and faulty sets have been obtained, and we know that every module in  $F_0$  is faulty. We have no reason to believe that  $F_0$  contains all the faulty modules. We could use the fact [8] that  $F = L(G)$ , where

$$L(G) = \{ U_j \mid U_j \in L(U_i), U_i \in G \}$$

whenever  $(G, F)$  is a minimal consistent partition, to search for the minimal consistent partitions, but this search may be tedious. We will now present a property of the implied faulty sets that holds when the Hakimi-Amin [3] sufficient conditions for one-step  $\tau$ -diagnosability are satisfied.

**Hypothesis 2 (Hakimi-Amin):**

- (i) every module is tested by at least  $\tau$  other modules;
- (ii) no two modules test each other.

We know from [3] that Problem 1 possesses a unique solution whenever Hypotheses 1 and 2 are satisfied and the number of faulty modules is not greater than  $\tau$ . In such a case, the implied faulty sets possess a property that greatly simplifies the task of decoding syndromes.

**Theorem 1:** If Hypotheses 1 and 2 are satisfied, and if  $1 \leq |F_S| \leq \tau$ , then at

least one module  $U_i$  in  $S$  exists such that either  $M(U_i) \cap L(U_i) \neq \phi$ , or  $\|L(U_i)\| \geq \tau+1$ , or both.

**Proof:** See Appendix.

We may use Theorem 1 to exhibit a maximality property of the implied faulty sets. If  $F_S$  is non-empty and if  $F_0$  is empty, then at least one module  $U_i$  exists so that  $\|L(U_i)\| \geq \tau + 1$ ; thus, the modules  $U_j$  in  $S$  that maximize  $\|L(U_j)\|$  are faulty.

**Corollary 1:** If Hypotheses 1 and 2 are satisfied, if  $1 \leq \|F_S\| \leq \tau$  and if  $M(U_i) \cap L(U_i) = \phi$  for every module in  $S$ , then the modules  $U_j$  that maximize  $\|L(U_j)\|$  are in  $F_S$ .

Corollary 1 may be used recursively to generate the set  $F_S$  of faulty modules in  $S$ , and thus, when Hypotheses 1 and 2 are satisfied, an iterative "greedy-type" algorithm will produce the set of faulty modules, provided that the set  $F_0$  is first identified.

**Algorithm 1:**

Step 0: Let  $F_0 = \{ U_i \in S \mid M(U_i) \cap L(U_i) \neq \phi \}$ , and let  $k = 0$ .

Step 1: Let  $h_k = \max \{ \|L(U_i) \cap (S - F_k)\| \mid U_i \in S - F_k \}$ .

Step 2: If  $h_k = 0$ , let  $F_A = F_k$  and stop; otherwise, go to Step 3.

Step 3: Let  $H_k = \{ U_i \in S - F_k \mid \|L(U_i) \cap (S - F_k)\| = h_k \}$ .

Step 4: Let  $F_{k+1} = F_k \cup H_k$ .

Step 5: Let  $k = k+1$ , and go to Step 1.

The fact that  $S$  contains a finite number of modules implies that Algorithm 1 terminates after a finite number of iterations. Using Lemma 1, Theorem 1 and Corollary 1, we may then obtain the following result.

**Theorem 2:** If Hypotheses 1 and 2 are satisfied, and if  $|F_S| \leq \tau$ , the set  $F_A$  generated by Algorithm 1 is equal to the set of faulty modules  $F_S$ .

# APPENDIX: Proof of Theorem 1

Our proof of Theorem 1 is similar to the one used by Hakimi and Amin in [3]. First, we assume that the result of the theorem does not hold; we then partition the system  $S$  and using that partition, we exhibit two inequalities which taken together, lead to a contradiction. Thus, in this appendix we shall assume that we have a *PMC* system level model in which:

- (A1) every module is tested by at least  $\tau$  other modules,
- (A2) no two modules test each other,
- (A3) the number of faulty modules  $|F_S|$  satisfies  $1 \leq |F_S| \leq \tau$ ,
- (A4)  $M(U_i) \cap L(U_i) = \phi$  for every module  $U_i$  in  $S$ , and
- (A5)  $|L(U_i)| \leq \tau$  for every module  $U_i$  in  $S$ .

Let  $U_*$  be a faulty module in  $S$  such that for every faulty module  $U_i$  in  $S$ ,

$$|M(U_*) \cap F_S| \geq |M(U_i) \cap F_S|. \quad (1)$$

We now partition our system  $S$  into five subsets:  $V_1, V_2, V_3, V_4$  and  $V_5$ .

Let  $V_1 = M(U_*) \cap F_S$ . Thus,  $V_1$  consists of all the modules in  $F_S$  that must be nonfaulty if  $U_*$  is assumed to be nonfaulty and  $U_*$  is in  $V_1$ .

Let  $V_2$  be the subset of  $S$  that consists of all the modules in  $L(U_*)$  that are actually faulty, i.e.,

$$V_2 = L(U_*) \cap F_S.$$

Let  $V_3$  be the set of all faulty modules that are not in  $V_1$  or  $V_2$ , i.e.,

$$V_3 = F_S - (V_1 \cup V_2).$$

Let  $V_4$  be the subset of  $S$  that consists of all the modules in the implied faulty set of  $U_*$  that are actually nonfaulty, i.e.,

$$V_4 = L(U_*) \cap G_S.$$

Let  $V_5$  be the set of all nonfaulty modules that are not in  $L(U_*)$ , i.e.,

$$V_5 = G_S - V_4.$$

Clearly, the sets  $V_1, V_2$  and  $V_3$  form a partition for  $F_S$ , and the sets  $V_4$  and  $V_5$  form a partition for  $G_S$ .

For  $i = 1, 2, 3, 4, 5$  and  $j = 1, 2, 3, 4, 5$ , let  $E_{i,j}$  be the set of testing links from  $V_i$  into  $V_j$ , let  $v_i$  denote the cardinality of the partition block  $V_i$ , let  $e_{i,j}^0$  denote the cardinality of the set of 0-links from  $V_i$  to  $V_j$ , let  $e_{i,j}^1$  denote the cardinality of the sets of 1-links from  $V_i$  to  $V_j$ , and let  $e_{i,j} = e_{i,j}^0 + e_{i,j}^1$ , i.e.,  $e_{i,j}$  is the cardinality of the set of testing links  $E_{i,j}$ .

The definition of the partition blocks  $V_i$  implies that the number and type of testing links between blocks may not be arbitrary.

**Lemma 2:** The testing links sets  $E_{i,j}$  satisfy:

- (i)  $e_{1,3} = e_{5,1} = e_{5,4} = 0$ ;
- (ii)  $E_{1,1}, E_{1,5}, E_{3,1}, E_{4,4}, E_{4,5}$  and  $E_{5,5}$  consists only of 0-links;
- (iii)  $E_{1,2}, E_{1,4}, E_{3,2}, E_{3,4}, E_{4,1}, E_{4,2}, E_{4,3}, E_{5,2}$  and  $E_{5,3}$  consist only of 1-links;
- (iv)  $E_{2,1}, E_{2,2}, E_{2,3}, E_{2,4}, E_{2,5}, E_{3,3}$  and  $E_{3,5}$  consist of both 0-links and 1-links.

**Proof:** Let  $U_i$  be in  $V_1$ , and let  $U_j$  be in  $S$ . If a 0-link from  $U_i$  to  $U_j$  exists, then  $U_j$  must be in  $V_1 \cup V_5$ , and if there is a 1-link from  $U_i$  to  $U_j$ , then  $U_j$  must be in  $L(U_*)$  and hence, in  $V_2 \cup V_4$ . We may then conclude that  $E_{1,1}$  and  $E_{1,5}$  consist of only 0-links, that  $E_{1,2}$  and  $E_{1,4}$  consist of only 1-links, and

that  $e_{1,3} = 0$ .

Let  $U_i$  be in  $V_3$ , and let  $U_j$  be in  $S$ . If a 0-link from  $U_i$  to  $U_j$  exists, then  $U_j$  must be in  $V_1 \cup V_3 \cup V_5$ ; if there is a 1-link from  $U_i$  to  $U_j$ , then  $U_j$  must be in  $V_2 \cup V_3 \cup V_4 \cup V_5$ . We may then conclude that  $E_{3,1}$  consists of only 0-links, and that  $E_{3,2}$  and  $E_{3,4}$  consist of only 1-links.

Let  $U_i$  be in  $V_4$ , and let  $U_j$  be in  $S$ . By construction,  $U_i$  is non faulty and  $U_j$  is faulty whenever  $U_j$  is in  $V_1 \cup V_2 \cup V_3$ ;  $U_j$  is non faulty whenever  $U_j$  is in  $V_4 \cup V_5$ . We may then conclude that  $E_{4,1}$ ,  $E_{4,2}$  and  $E_{4,3}$  consist of only 1-links, and that  $E_{4,4}$  and  $E_{4,5}$  consist of only 0-links.

We cannot have any testing links from  $V_5$  to  $V_1$  or  $V_4$ , because whenever a non faulty module tests a module in either  $V_1$  or  $V_4$ , it must be in  $L(U_*)$ , thus  $e_{5,1} = e_{5,4} = 0$ . By construction, a module  $U_i$  in  $V_5$  is non faulty and thus,  $E_{5,2}$  and  $E_{5,3}$  consist of only 1-links, and  $E_{5,5}$  consists of only 0-links.  $\square$

Every module is tested by at least  $\tau$  other modules, and therefore,

$$e_{1,1} + e_{2,1} + e_{3,1} + e_{4,1} \geq \tau v_1, \quad (2)$$

and

$$e_{1,4} + e_{2,4} + e_{3,4} + e_{4,4} \geq \tau v_4 \quad (3)$$

No two modules test each other, and thus

$$e_{1,1} \leq v_1(v_1-1)/2, \quad (4)$$

$$e_{4,4} \leq v_4(v_4-1)/2, \quad (5)$$

$$e_{1,4} + e_{4,1} \leq v_1 v_4 \quad (6)$$

and

$$e_{2,4} \leq v_2 v_4 \quad (7)$$

The fact that  $|L(U_i)| \leq \tau$  for every module  $U_i$  in  $S$  implies that the number of 1-links from a partition block  $V_i$  to  $S$  cannot be larger than the number of 0-links from  $S$  to  $V_i$ , and therefore,

$$e_{2,1}^1 + e_{2,2}^1 + e_{2,3}^1 + e_{2,4}^1 \leq e_{2,2}^0, \quad (8)$$

and

$$e_{3,4} \leq e_{2,3}^0 + e_{3,3}^0. \quad (9)$$

The maximality of the module  $U_*$  on which the basic partition is based implies that no faulty module may find more than  $v_1-1$  faulty modules non faulty, and thus,

$$e_{2,1}^0 + e_{2,2}^0 + e_{2,3}^0 \leq v_2(v_1-1), \quad (10)$$

and

$$e_{3,1} + e_{3,3}^0 \leq v_3(v_1-1). \quad (11)$$

Equations (2) and (4) imply

$$e_{4,1} \geq \tau v_1 - v_1(v_1-1)/2 - e_{2,1} - e_{3,1}. \quad (12)$$

Equations (3), (5) and (7) imply

$$e_{1,4} \geq \tau v_4 - v_2 v_4 - e_{3,4} - v_4(v_4-1)/2. \quad (13)$$

Thus, using (6), we obtain

$$X + Y \geq 0 \quad (14)$$

where

$$X = v_1 v_4 - \tau v_1 + v_1(v_1-1)/2 - \tau v_4 + v_4(v_4-1)/2 + v_2 v_4, \quad (15)$$

and

$$Y = e_{2,1} + e_{3,1} + e_{3,4}. \quad (16)$$

Using (9), we obtain

$$Y \leq e_{2,1} + e_{3,1} + e_{2,3}^0 + e_{3,3}^0 \quad (17)$$

and using (11), we find that

$$Y \leq e_{2,1} + e_{2,3}^0 + v_3(v_1-1). \quad (18)$$

Inequalities (8) and (10) yield

$$e_{2,1}^1 + e_{2,2}^1 + e_{2,3}^1 + e_{2,4}^1 + e_{2,1}^0 + e_{2,2}^0 + e_{2,3}^0 \leq e_{2,2}^0 + v_2(v_1-1), \quad (19)$$

thus

$$e_{2,1}^0 + e_{2,1}^1 + e_{2,3}^0 \leq v_2(v_1-1), \quad (20)$$

and we may conclude that

$$e_{2,1} + e_{2,3}^0 \leq v_2(v_1-1). \quad (21)$$

Using (18) and (21), we obtain

$$Y \leq v_3(v_1-1) + v_2(v_1-1). \quad (22)$$

The number of faulty modules is at most  $\tau$ , i.e.,

$$v_1 + v_2 + v_3 \leq \tau, \quad (23)$$

and thus

$$v_1(v_1-1)/2 + v_2(v_1-1) + v_3(v_1-1) \leq \tau(v_1-1) - v_1(v_1-1)/2. \quad (24)$$

The fact that  $|L(U_i)| \leq \tau$  for every module  $U_i$  in  $S$  implies that  $v_2 + v_4 \leq \tau$ , and thus

$$v_2 \leq \tau - v_4. \quad (25)$$

Using (14), (15), (16), (22), (24) and (25), we obtain

$$v_1 v_4 - \tau v_1 + \tau(v_1-1) - v_1(v_1-1)/2 - \tau v_4 + v_4(v_4-1)/2 + (\tau - v_4)v_4 \geq 0. \quad (26)$$



Equation (26) may be rewritten as

$$(v_1 - v_4)/2 - (v_1 - v_4)^2/2 - \tau \geq 0. \quad (27)$$

It is easy to verify that

$$(v_1 - v_4)/2 - (v_1 - v_4)^2/2 \leq 0.125 \quad (28)$$

for all values of  $v_1$  and  $v_4$ , and thus

$$0.125 - \tau \geq 0. \quad (29)$$

Equation (29) implies that  $\tau$  must be equal to 0, and this contradicts (A3).

We have shown that the five basic assumptions given at the beginning of the appendix lead to a contradiction and thus may not hold. We can therefore conclude that if a *PMC* model satisfies (A1), (A2) and (A3), then (A4) and (A5) may not hold simultaneously; that is, if (A1), (A2) and (A3) hold, then at least one module  $U_i$  in  $S$  exists so that either (i)  $M(U_i) \cap L(U_i) \neq \phi$ , or (ii)  $|L(U_i)| \geq \tau + 1$ , or both.

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REPORT DOCUMENTATION PAGE		READ INSTRUCTIONS BEFORE COMPLETING FORM
1. REPORT NUMBER JHU/EECS-83/03	2. GOVT ACCESSION NO. AD-A129 385	3. RECIPIENT'S CATALOG NUMBER
4. TITLE (and Subtitle) The PMC System Level Fault Model: Maximality Properties of the Implied Faulty Sets		5. TYPE OF REPORT & PERIOD COVERED Technical
		6. PERFORMING ORG. REPORT NUMBER
7. AUTHOR(s) Gerard G. L. Mayer		8. CONTRACT OR GRANT NUMBER(s) N00014-80-C-0772
9. PERFORMING ORGANIZATION NAME AND ADDRESS The Johns Hopkins University Baltimore, MD 21218		10. PROGRAM ELEMENT, PROJECT, TASK AREA & WORK UNIT NUMBERS
11. CONTROLLING OFFICE NAME AND ADDRESS Office of Naval Research Arlington, VA 22217		12. REPORT DATE May 15, 1983
		13. NUMBER OF PAGES 16
14. MONITORING AGENCY NAME & ADDRESS (if different from Controlling Office)		15. SECURITY CLASS. (of this report) Unclassified
		15a. DECLASSIFICATION/DOWNGRADING SCHEDULE
16. DISTRIBUTION STATEMENT (of this Report)  Approved for public release; distribution unlimited		
17. DISTRIBUTION STATEMENT (of the abstract entered in Block 20, if different from Report)		
18. SUPPLEMENTARY NOTES		
19. KEY WORDS (Continue on reverse side if necessary and identify by block number)  Fault analysis; fault location; faulty sets; system level fault model		
20. ABSTRACT (Continue on reverse side if necessary and identify by block number) In this paper, we examine the implied faulty sets in the case of the PMC system level fault model. We show that those sets possess a maximality property whenever: the system is one-step $\mathcal{E}$ -diagnosable, no two modules test each other and the number of faulty modules is no larger than $\mathcal{E}$ . In addition, we propose a syndrome-decoding algorithm based on that maximality property.		

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